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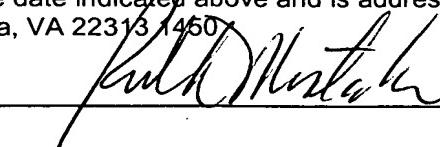
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Date: 07/17/06

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Attorney's Docket No.: GK-ZEI-3303/500343.20324

U.S. Application No.:

International Application No.: PCT/EP2005/001164

International Filing Date: FEBRUARY 04, 2005

04 FEBRUARY 2005

Priority Date Claimed: FEBRUARY 06, 2004

06 FEBRUARY 2004

APRIL 27, 2004

27 APRIL 2004

Title of Invention: SHORT-COHERENCE INTERFEROMETRIC MEASUREMENT OF LENGTH ON THE EYE

Applicant(s) for (DO/EO/US): Adolf Friedrich FERCHER

Mail Stop PCT
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-450

INFORMATION DISCLOSURE STATEMENT

SIR:

Applicant herewith submits together with the simultaneously filed National Phase application of PCT/EP2005/001164 a copy of the International Search Report (PCT/ISA/210) dated June 23, 2005, citing the following references:

	Document Number	Date	Name and/or Country	English Translation and/or Equivalent
AL	32 01 801	09/08/1983	Germany	Abstract only
AM	92/19930	11/12/1992	WIPO	n/a
AN	196 24 167	01/16/1997	Germany	US equivalent 5,847,827
AO	01/38820	05/31/2001	WIPO	Abstract only
AP	02/04884	01/17/2002	WIPO	Abstract only
AQ	03/086180	10/23/2003	WIPO	Abstract only

Accompanying this Information Disclosure Statement and form PTO-1449 are copies of the foreign documents w/English Abstracts. Documents AL and AO are mentioned on pages 2 and 3 of the substitute specification.

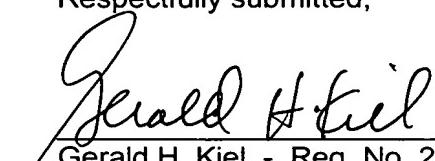
The USPTO waived the requirement under 37 C.F.R. §1.98(a)(2)(i) for submitting copies of US patents and US patent application publications in all U.S. applications filed after June 30, 2003. First pages of US documents only.

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This submission is not an admission that the information disclosed in the documents is material to the patentability of the invention disclosed and/or claimed in the above-identified application.

Respectfully submitted,



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Enclosures:

Search Report (PCT/ISA/210);
PTO-1449
2 DE documents w/1 English Abstract and
1 first page US equivalent
4 WO documents incl. 3 English Abstracts

LIST OF PRIOR ART CITED BY APPLICANT
 (Filed on July 17, 2006)

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Docket No. GK-ZEI-3303/500343.20324

JAP20 Rec'd PCT/PTO 17 JUL 2005

Applicant(s): Adolf Friedrich FERCHER

Application No. (Int'l Appln No. PCT/EP2005/001164 04FEB05) Group:

Filed: Concurrently herewith - July 17, 2006

Examiner:

U.S. PATENT DOCUMENTS

Exam. Init		Document Number	Date	Name	Class	Sub- Class	Filing Date Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	CLASS	Sub- Class	Translation YES NO
	AL	32 01 801	09/08/1983	Germany			Abstract only
	AM	92/19930	11/12/1992	WIPO			n/a
	AN	196 24 167	01/16/1997	Germany			US 5,847,827
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	AP	02/04884	01/17/2002	WIPO			Abstract only
	AQ	03/086180	10/23/2003	WIPO			Abstract only
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OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.